

I. INTRODUCTION

Wave propagation in periodic layered media is very similar to the motion of electrons in crystalline solids (hence, they are also known as photonic crystals). Thus, it is hardly surprising that some well-established concepts of solid-state physics (such as Bloch waves, Brillouin zones, and forbidden bands) have been incorporated in the doctrine of photonic crystals [1].

The standard approach [2] identifies the periodic structure with a one-dimensional lattice that is invariant under lattice translations, which requires the system to be strictly infinite. Of course, this is unattainable in practice. In solid-state physics one goes around this difficulty by considering that the one-dimensional lattice closes into a ring; i.e., by imposing periodic boundary conditions. While this seems to be reasonable for a lattice of atoms, is obviously unfeasible for periodically stratified media.

In spite of this fact, only under the assumption of an endlessly repeating stack of dielectric slabs this standard treatment gets an eigenvalue equation for the Bloch factor and then one finds [3, 4, 5, 6, 7] that strong reflection (stop bands) occurs when the trace of the 2×2 matrix describing the basic period exceeds 2 in magnitude.

In practice not very many periods (say, ten) are needed to have a stop band. Therefore, one is led to consider stacks of N periods, which are often appropriately called “finite” periodic structures [8]. The matrix describing these structures can be computed as the N th power of the basic period in terms of Chebyshev polynomials [9, 10]. This gives an exact expression for the reflectance, but so complicated that it is difficult to get, at first glance, any feeling about the performance of the system. Moreover, the distinction between allowed and forbidden bands is obtained only numerically.

The aim of this paper is to provide an alternative setting for dealing with these finite periodic structures that stresses the different scaling laws appearing in the reflectance. To this end we resort to the Iwasawa decomposition to represent the action of any multilayer as the product of three fundamental matrices of simple interpretation. We show that these matrices present quite distinct reflectances. The trace of the basic period allows us to classify periodic structures in three types with properties closely related to one (and only one) of the three fundamental matrices. Finally, we study the reflectance associated to each one of these types.

The advantage of this approach is, in our view, twofold: it naturally emphasizes the different laws for the forbidden bands, allowed bands, and band edges and, at the same time, provides universal expressions remarkably simple for the corresponding reflectances.

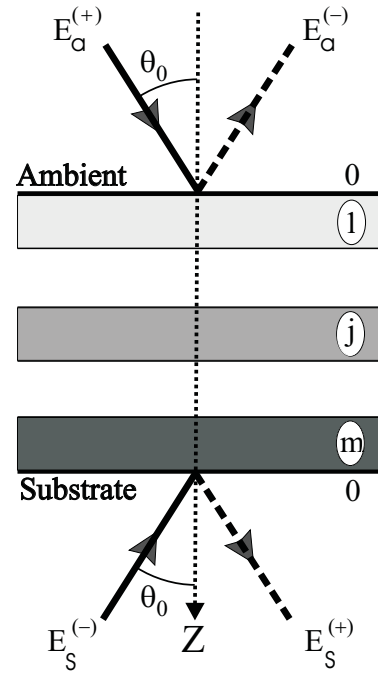


FIG. 1: Wave vectors of the input [$E_a^{(+)}$ and $E_s^{(-)}$] and the output [$E_a^{(-)}$ and $E_s^{(+)}$] fields in a multilayer sandwiched between two identical semi-infinite ambient and substrate media.

II. THE ORIGIN OF THE BANDGAP IN INFINITE PERIODIC STRUCTURES

To keep the discussion as self-contained as possible, we first briefly summarize the essential ingredients of multilayer optics that we shall need for our purposes. The basic period of the structure is illustrated in Fig. 1 and consists of a stack of $1, \dots, j, \dots, m$ plane-parallel layers sandwiched between two semi-infinite ambient (a) and substrate (s) media, which we shall assume to be identical, since this is the common experimental case. Hereafter all the media are supposed to be lossless, homogeneous, and isotropic.

We consider an incident monochromatic linearly polarized plane wave from the ambient that makes an angle θ_0 with the normal to the first interface and has amplitude $E_a^{(+)}$. The electric field is either in the plane of incidence (p polarization) or perpendicular to the plane of incidence (s polarization). We consider as well another plane wave of the same frequency and polarization, and with amplitude $E_s^{(-)}$, incident from the substrate at the same angle θ_0 .

As a result of multiple reflections in all the interfaces [11], we have a backward-traveling plane wave in the ambient, denoted $E_a^{(-)}$, and a forward-traveling plane wave in the substrate, denoted $E_s^{(+)}$. If we take the field

amplitudes as a vector of the form

$$\vec{E} = \begin{pmatrix} E^{(+)} \\ E^{(-)} \end{pmatrix}, \quad (1)$$

which applies to both ambient and substrate media, then the amplitudes at each side of the multilayer are related by the 2×2 complex matrix M_{as} , we shall call the transfer matrix, in the form

$$\vec{E}_a = M_{as} \vec{E}_s. \quad (2)$$

The matrix M_{as} can be shown to be of the form [12, 13]

$$M_{as} = \begin{pmatrix} 1/T_{as} & R_{as}^*/T_{as}^* \\ R_{as}/T_{as} & 1/T_{as}^* \end{pmatrix} \equiv \begin{pmatrix} \alpha & \beta \\ \beta^* & \alpha^* \end{pmatrix}, \quad (3)$$

where the complex numbers

$$R_{as} = |R_{as}| \exp(i\rho), \quad T_{as} = |T_{as}| \exp(i\tau), \quad (4)$$

are, respectively, the overall reflection and transmission coefficients for a wave incident from the ambient. Note that we have $\det M_{as} = +1$, which is equivalent to $|R_{as}|^2 + |T_{as}|^2 = 1$, and then the set of lossless multilayer matrices reduces to the group $SU(1,1)$, whose elements depend on three independent real parameters [14, 15].

The identity matrix corresponds to $T_{as} = 1$ and $R_{as} = 0$, so it represents an antireflection system without transmission phase shift. The matrix that describes the overall system obtained by putting two multilayers together is the product of the matrices representing each one of them, taken in the appropriate order. So, two multilayers, which are inverse, when composed give an antireflection system.

When we repeat the basic period M_{as} the fields at the n th cell are given by

$$\vec{E}_{n+1} = M_{as} \vec{E}_n. \quad (5)$$

In an infinite structure the Floquet theorem ensures that these cells are equivalent and so the two vectors in Eq. (5) are proportional [2, 8]

$$\vec{E}_{n+1} = \lambda \vec{E}_n, \quad (6)$$

and therefore the Bloch factor λ is determined as the eigenvalue of the basic-period transfer matrix M_{as} :

$$(M_{as} - \lambda) \vec{E}_n = 0, \quad (7)$$

which gives

$$\lambda^2 - [\text{Tr}(M_{as})]\lambda + 1 = 0. \quad (8)$$

If $[\text{Tr}(M_{as})]^2 > 4$, the solution grows or decays exponentially and no propagating wave is possible (stop band). On the contrary, Bloch waves appear in this algebraic approach when $[\text{Tr}(M_{as})]^2 < 4$ and then the matrix M_{as} has two eigenvalues (allowed band). The band edges

are obtained by setting $[\text{Tr}(M_{as})]^2 = 4$. Such a periodic structure exhibits resonance reflection very much like the diffraction of X rays by crystal lattice planes and, in consequence, it is usually called a Bragg reflector [2]. By properly designing the basic period it is possible to achieve extremely high reflectance for some selected spectral region [16].

III. FINITE PERIODIC STRUCTURES AND IWASAWA DECOMPOSITION

As anticipated in the Introduction, an infinite multilayer is unrealistic in practice, and one should consider N -period finite structures, for which the previous standard approach fails [17, 18].

The overall transfer matrix $M_{as}^{(N)}$ for a N -period structure is equal to $(M_{as})^N$. Explicit but complicated formulas for the corresponding matrix elements exist [9, 10], but they do not give analytic expressions for the bandgap and are difficult to analyze.

We have recently advocated using the Iwasawa decomposition to study layered media [19], since it provides a remarkable factorization of the matrix representing any multilayer (no matter how complicated it could be) as the product of three matrices of simple interpretation. The decomposition can be stated as

$$M_{as} = K(\phi)A(\xi)N(\nu), \quad (9)$$

where

$$\begin{aligned} K(\phi) &= \begin{pmatrix} \exp(i\phi/2) & 0 \\ 0 & \exp(-i\phi/2) \end{pmatrix}, \\ A(\xi) &= \begin{pmatrix} \cosh(\xi/2) & i \sinh(\xi/2) \\ -i \sinh(\xi/2) & \cosh(\xi/2) \end{pmatrix}, \\ N(\nu) &= \begin{pmatrix} 1 - i\nu/2 & \nu/2 \\ \nu/2 & 1 + i\nu/2 \end{pmatrix}. \end{aligned} \quad (10)$$

The parameters ϕ, ξ , and ν are given in terms of the elements of the multilayer matrix by

$$\begin{aligned} \phi/2 &= \arg(\alpha + i\beta), \\ \xi/2 &= \ln(1/|\alpha + i\beta|), \\ \nu/2 &= \text{Re}(\alpha\beta^*)/|\alpha + i\beta|^2, \end{aligned} \quad (11)$$

and their ranges are $\xi, \nu \in \mathbb{R}$ and $-2\pi \leq \phi \leq 2\pi$. Now, we can interpret the physical action of the matrices appearing in Eq. (9). $K(\phi)$ represents the free propagation of the fields $\vec{E}$ in the ambient medium through an optical phase thickness of $\phi/2$, which reduces to a mere shift of the origin of phases. Alternatively, this can be seen as an antireflection system. The second matrix $A(\xi)$ represents a symmetric system with real transmission coefficient $T_A = \text{sech}(\xi/2)$ and reflection phase shift $\rho_A = \pm\pi/2$. Finally, the third matrix, $N(\nu)$, represents a system having $T_N = \cos(\tau_N) \exp(i\tau_N)$ and $R_N = \sin(\tau_N) \exp(i\tau_N)$,

with $\tan(\tau_N) = \nu/2$. In Ref. [12] we have provided simple examples of realistic systems that accomplish these requirements.

For our purposes here, the essential point is that the reflectance $\mathfrak{R} = |R|^2$ associated to each one of these matrices is

$$\begin{aligned}\mathfrak{R}_K &= 0, \\ \mathfrak{R}_A &= \tanh^2(\xi/2), \\ \mathfrak{R}_N &= (\nu/2)^2/[1 + (\nu/2)^2].\end{aligned}\quad (12)$$

While $\mathfrak{R}_K$ is identically zero, $\mathfrak{R}_A$ and $\mathfrak{R}_N$ tend to unity when ξ and ν , respectively, increase. However, they have distinct growth: $\mathfrak{R}_A$ goes to unity exponentially, while $\mathfrak{R}_N$ goes as $O(\nu^{-2})$.

The Iwasawa decomposition proves also to be a powerful tool for the classification of layered media. Indeed, after Ref. [20] one is led to introduce the following criterion: a matrix is of type K when $[\text{Tr}(\mathbf{M}_{as})]^2 < 4$, is of type A when $[\text{Tr}(\mathbf{M}_{as})]^2 > 4$, and finally is of type N when $[\text{Tr}(\mathbf{M}_{as})]^2 = 4$. Although this trace criterion has an elegant geometrical interpretation [13] and coincides with the one giving the stop bands in Eq. (8), let us remark that if a multilayer has a transfer matrix $\mathbf{M}_{as}$ of type K, A, or N, one can always find a family of matrices $\mathbf{C}$ [also in $\text{SU}(1,1)$] such that

$$\widehat{\mathbf{M}}_{as} = \mathbf{C} \mathbf{M}_{as} \mathbf{C}^{-1} \quad (13)$$

is just a matrix $\mathbf{K}(\phi)$, $\mathbf{A}(\xi)$, or $\mathbf{N}(\nu)$, respectively. This conjugation by $\mathbf{C}$ preserves the trace: $\text{Tr}(\widehat{\mathbf{M}}_{as}) = \text{Tr}(\mathbf{M}_{as})$. Moreover, Eq. (13) allows us to recast the multilayer action in Eq. (2) as

$$\widehat{\vec{E}}_a = \widehat{\mathbf{M}}_{as} \widehat{\vec{E}}_s, \quad (14)$$

where the new field vectors are

$$\widehat{\vec{E}} = \mathbf{C} \vec{E}. \quad (15)$$

In other words, the matrix $\mathbf{C}$ gives a new vector basis such that the basic period of the system, when viewed in such a basis, presents a reflectance exactly of the form in Eq. (12). This provides a full characterization of the reflectance of any periodic system, as we shall demonstrate in next Section.

IV. CHARACTERIZING THE THREE FUNDAMENTAL BEHAVIORS OF THE REFLECTANCE

Since the matrix $\widehat{\mathbf{M}}_{as}$ associated to the basic period belongs to one of the subgroups $\mathbf{K}(\phi)$, $\mathbf{A}(\xi)$, or $\mathbf{N}(\nu)$ of the Iwasawa decomposition, and all these subgroups are, in our special case, Abelian and uniparametric, we have that

$$\widehat{\mathbf{M}}_{as}(\mu_1) \widehat{\mathbf{M}}_{as}(\mu_2) = \widehat{\mathbf{M}}_{as}(\mu_1 + \mu_2), \quad (16)$$

where μ represents the appropriate parameter ϕ , ξ , or ν . For a N -period system the overall transfer matrix $\mathbf{M}_{as}^{(N)}$ is

$$\mathbf{M}_{as}^{(N)} = \mathbf{C}^{-1} [\widehat{\mathbf{M}}_{as}(\mu)]^N \mathbf{C} = \mathbf{C}^{-1} \widehat{\mathbf{M}}_{as}(N\mu) \mathbf{C}, \quad (17)$$

which does not depend on the explicit form of the basic period.

After Eq. (17), one must expect three universal behaviors of the reflectance according the basic-period transfer matrix is of the type K, A or N. We shall work in what follows the detailed structure of these three basic laws.

Because the stop bands are given by the condition $[\text{Tr}(\mathbf{M}_{as})]^2 > 4$, we first consider the case when $\mathbf{M}_{as}$ is of type A. Then, Eq. (13) gives

$$\mathbf{M}_{as} = \mathbf{C}^{-1} \mathbf{A}(\chi) \mathbf{C}, \quad (18)$$

where we have denoted

$$\text{Re}(\alpha) = \frac{1}{2} \text{Tr}(\mathbf{M}_{as}) = \cosh(\chi) > 1, \quad (19)$$

because we are taking into account only positive values of $\text{Re}(\alpha)$, since negative values can be treated much in same way. If we put

$$\mathbf{C} = \begin{pmatrix} \mathfrak{c}_1 & \mathfrak{c}_2 \\ \mathfrak{c}_2^* & \mathfrak{c}_1^* \end{pmatrix}, \quad (20)$$

one solution of Eq. (18) is

$$\mathfrak{c}_1 = F(\beta^* + i \sinh \chi), \quad \mathfrak{c}_2 = -iF \text{Im}(\alpha), \quad (21)$$

where the factor F is

$$F = \frac{1}{\sqrt{2 \sinh \chi [\sinh \chi - \text{Im}(\beta)]}}. \quad (22)$$

Carrying out the matrix multiplications in Eq. (17) it is easy to obtain the reflectance of the N -period system as

$$\mathfrak{R}_A^{(N)} = \frac{|\beta|^2}{|\beta|^2 + [\sinh(\chi)/\sinh(N\chi)]^2}. \quad (23)$$

This is an exact expression for any value of N . As N grows, $\mathfrak{R}_A^{(N)}$ approaches unity exponentially, as one could expect from a band stop.

The band edges are determined by the limit condition $[\text{Tr}(\mathbf{M}_{as})]^2 = 4$; that is, when $\mathbf{M}_{as}$ is of type N. A calculation very similar to the previous one shows that now

$$\mathfrak{R}_N^{(N)} = \frac{|\beta|^2}{|\beta|^2 + (1/N)^2}, \quad (24)$$

with a typical behavior $\mathfrak{R}_N^{(N)} \sim 1 - O(N^{-2})$ that is universal in the physics of reflection. The general results (23) and (24) have been obtained in a different framework by Yeh [2] and Lekner [8].

Finally, in the allowed bands we have $[\text{Tr}(\mathbf{M}_{as})]^2 < 4$; $\mathbf{M}_{as}$ is of type K, and

$$\Re_{\mathbf{K}}^{(N)} = \frac{Q^2 - 2Q \cos(2N\Omega)}{1 + Q^2 - 2Q \cos(2N\Omega)}, \quad (25)$$

where

$$Q = \frac{|\beta|^2}{|\beta|^2 - |\alpha - e^{i\Omega}|^2}, \quad (26)$$

and the phase Ω is determined by

$$e^{i\Omega} = (\text{Re } \alpha) + i\sqrt{1 - (\text{Re } \alpha)^2}. \quad (27)$$

Now the reflectance oscillates with N between the values $(Q^2 - 2Q)/(Q - 1)^2$ and $(Q^2 + 2Q)/(Q + 1)^2$.

Equations (23), (24) and (25) are the three fundamental reflectances we were looking for. In our opinion, they have the virtue of simplicity. In practice, the basic period usually consists of two homogeneous layers and the expressions become simpler [9]. We emphasize that the

scaling laws expressed by these equations are universal features of the reflection in finite periodic systems.

V. CONCLUSIONS

We have used a trace criterion to provide in a direct way three fundamental forms for the reflectance that are universal for any multilayer. When the system is finite periodic this result has allowed us to obtain in a direct way explicit expressions for the reflectance of the overall system.

This approach has physical meaning on its own, irrespective whether the system is periodic or not. Moreover, it leads naturally to a further analysis of finite periodic bandgap structures that does not need the strict requirement of infinite periodicity, as it is assumed in the standard theory.

We acknowledge illuminating discussions with José F. Cariñena.

-
- [1] J. D. Joannopoulos, R. D. Meade, and J. N. Winn, *Photonic Crystals* (U. Princeton Press, Princeton, N. J., 1995).
 - [2] P. Yeh, *Optical Waves in Layered Media* (Wiley, New York, 1988) Chap. 6.
 - [3] P. Yeh, A. Yariv, and C. S. Hong, "Electromagnetic propagation in periodic stratified media. I. General theory," *J. Opt. Soc. Am.* **67**, 423-438 (1977).
 - [4] Y. Fink, J. N. Winn, S. Fan, C. Chen, J. Michel, J. D. Joannopoulos, and E. L. Thomas, "A dielectric omnidirectional reflector," *Science* **282**, 1679-1682 (1998).
 - [5] J. P. Dowling, "Mirror on the wall: you're omnidirectional after all?," *Science* **282**, 1841-1842 (1998).
 - [6] E. Yablonovitch, "Engineered omnidirectional external-reflectivity spectra from one-dimensional layered interference filters," *Opt. Lett.* **23**, 1648-1649 (1998).
 - [7] J. Lekner, "Omnidirectional reflection by multilayer dielectric mirrors," *J. Opt. A: Pure Appl. Opt.* **2**, 349-352 (2000).
 - [8] J. Lekner, "Light in periodically stratified media," *J. Opt. Soc. Am. A* **11**, 2892-2899 (1994).
 - [9] M. Born and E. Wolf, *Principles of Optics* (Cambridge U. Press, Cambridge, 1999) 7 ed. Sec. 1.6.5.
 - [10] J. Lekner, *Theory of Reflection* (Kluwer Academic, Dordrecht, The Netherlands, 1987).
 - [11] R. M. A. Azzam and N. M. Bashara, *Ellipsometry and Polarized Light* (North-Holland, Amsterdam, 1987) Sec. 4.6.
 - [12] T. Yonte, J. J. Monzón, L. L. Sánchez-Soto, J. F. Cariñena, and C. López-Lacasta, "Understanding multilayers from a geometrical viewpoint," *J. Opt. Soc. Am. A* **19**, 603-609 (2002).
 - [13] J. J. Monzón, T. Yonte, L. L. Sánchez-Soto, and J. F. Cariñena, "Geometrical setting for the classification of multilayers," *J. Opt. Soc. Am. A* **19**, 985-991 (2002).
 - [14] J. J. Monzón and L. L. Sánchez-Soto, "Lossless multilayers and Lorentz transformations: more than an analogy," *Opt. Commun.* **162**, 1-6 (1999).
 - [15] J. J. Monzón and L. L. Sánchez-Soto, "Fully relativistic-like formulation of multilayer optics," *J. Opt. Soc. Am. A* **16**, 2013-2018 (1999).
 - [16] W. H. Southwell, "Omnidirectional mirror design with quarter-wave dielectric stacks," *Appl. Opt.* **38**, 5464-5467 (1999).
 - [17] J. M. Bendickson, J. P. Dowling, and M. Scalora, "Analytic expressions for the electromagnetic mode density in finite, one-dimensional, photonic band-gap structures," *Phys. Rev. E* **53**, 4107-4121 (1996).
 - [18] E. Cojocar, "Forbidden gaps in finite periodic and quasi-periodic Cantor-like dielectric multilayers at normal incidence," *Appl. Opt.* **40**, 6319-6326 (2001).
 - [19] J. J. Monzón, T. Yonte, and L. L. Sánchez-Soto, "Basic factorization for multilayers," *Opt. Lett.* **26**, 370-372 (2001).
 - [20] L. L. Sánchez-Soto, J. J. Monzón, T. Yonte, and J. F. Cariñena, "Simple trace criterion for classification of multilayers," *Opt. Lett.* **26**, 1400-1402 (2001).